

Transition from minority to majority spin transport in iron-manganese nitride $Fe_{4-x}Mn_xN$ films with increasing x

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Herein, 30 nm-thick Fe_{4-x}Mn_xN (x = 0, 1, 2, 3, and 4) epitaxial films were grown on MgO(001) substrates by molecular beam epitaxy, and the anisotropic magnetoresistance (AMR) properties were measured at temperatures (*T*) between 10 and 300 K. A negative AMR effect was observed in the Fe₄N and FeMn₃N films at $T \le 300$ K and in the Mn₄N film at $T \le 100$ K. In contrast, a positive AMR effect was observed in the Fe₃MnN and Fe₂Mn₂N films at $T \le 300$ K. Using the relationship between the AMR ratio, the spin polarization of the density of states at the Fermi level, and the spin polarization of the electrical conductivity (P_{σ}), we derived the sign of P_{σ} to be negative in Fe₄N, Fe₃MnN, and Fe₂Mn₂N and to be positive in FeMn₃N and Mn₄N. These results show that the minority spin transport is dominant in Fe_{4-x}Mn_xN for x = 0, 1, and 2 at lower temperatures, whereas the majority spin transport is dominant with increasing x in Fe_{4-x}Mn_xN for x = 3 and 4. *Published by AIP Publishing*. https://doi.org/10.1063/1.5051721

I. INTRODUCTION

Anti-perovskite 3d nitrides and their mixed crystals have been investigated as spintronics materials both with theory and experiment.^{1–10} One of these nitrides, Mn_4N , satisfies both of the requirements of a perpendicular magnetic anisotropy (PMA) and a small saturation magnetization ($M_{\rm S}$). Specifically, a PMA has been reported for Mn₄N films grown on substrates composed of glass,¹¹ Si(001),¹² MgO(001),¹³⁻¹⁷ and SrTiO₃(001).^{13,18} Furthermore, the Mn₄N is a ferrimagnetic metal with $M_{\rm S} = 182 \, {\rm emu/cm^3}$ at 77 K and a high Curie temperature of 745 K.¹ Recently, we have achieved spin-transfer-torque-driven domain wall velocities greater than 230 m/s with current densities as small as 7×10^{11} A/m² in 1–2 µm-wide Mn₄N strips.¹⁹ These velocities surpass those found in FeNi (~ 100 m/s).²⁰ Such a fast domain wall propagation in Mn_4N is ascribed to the low M_S value and the presence of a PMA, originating from the specific chemical bonding between Mn and N atoms in the antiperovskite unit cell. The lattice structure of Mn₄N is shown in Fig. 1. The Mn atoms occupy the corner (I) and facecentered (II) sites and the N atom occupies the body-centered site. The II sites are further divided into IIA and IIB sites in the presence of magnetization (M) (arrow in Fig. 1).

Substitution of other 3*d* transition metal atoms for the Mn atoms in Mn₄N is an effective means to change the magnetic properties. For example, in Mn_{4-y}Co_yN, there is a tendency for the anisotropy field to increase as the Co content (i.e., *y* value) increases, whereas the M_S and uniaxial magnetic anisotropy energy decrease.¹⁸ However, the formation of Mn_{4-y}Co_yN is difficult to achieve because of the phase

separation, and thus, the *y* value of $Mn_{4-y}Co_yN$ is limited to ≤ 0.2 . Another example is $Fe_{4-x}Mn_xN^{.21-24}$ Although the magnetic properties of Fe_{4-r}Mn_rN have been theoretically predicted,²¹⁻²³ its formation has been limited to powders with a small Mn content ($x \le 0.75$). Very recently, we have achieved the epitaxial growth of $Fe_{4-x}Mn_xN$ (x = 0, 1, 2, 3, and 4) films by molecular beam epitaxy (MBE) and characterized their $M_{\rm S}$ values at room temperature (RT).²⁵ A PMA was observed in $Fe_{4-x}Mn_xN$ films at x = 3 and 4 at RT, though no PMA existed at $x \le 2$. However, the spin-polarization (P_D) of the density of states (D) at the Fermi level $(E_{\rm F})$, $P_{\rm D} = [D_{\uparrow}(E_{\rm F}) - D_{\downarrow}(E_{\rm F})]/[D_{\uparrow}(E_{\rm F}) + D_{\downarrow}(E_{\rm F})]$, and the spin polarization of the electrical conductivity (σ), $P_{\sigma} = (\sigma_{\uparrow} - \sigma_{\downarrow})/(\sigma_{\uparrow} + \sigma_{\downarrow})$, have yet to be investigated. Regarding ferromagnetic Fe₄N, Kokado et al. have calculated its $P_{\rm D}$ and P_{σ} values to be -0.6 and -1.0, respectively.²⁶ However, it has been considered difficult to experimentally obtain the sign of P_{σ} , though the sign is very important for devices wherein electrical conductivity plays a major role, such as giant magnetoresistance devices. Recently, several studies on magnetotransport properties in ferromagnetic materials such as the anisotropic magnetoresistance (AMR) effect have been conducted theoretically^{27–29} and experimentally.^{30–40} Kokado et al. have derived a general expression between the AMR ratio γ_{AMR} , P_D , and P_σ such that

$$\gamma_{\rm AMR} \propto -\left(\frac{\lambda}{H_{\rm ex}}\right)^2 P_{\rm D} P_{\sigma},$$
 (1)

which was derived from the two-current model²⁷ comprising a spin-polarized conduction state and localized d states



FIG. 1. Crystal structure of anti-perovskite-type 3*d* transition metal nitride. The II sites can be divided into IIA and IIB sites depending on the magnetization direction (arrow).

within the spin-orbit interaction. Here, λ is the spin-orbit coupling constant and H_{ex} is the exchange field. This enables the derivation of the sign of P_{σ} from those of P_{D} and γ_{AMR} . Using this expression, the fact that the minority spins dominate the electrical conductivity in Fe₄N has been confirmed by the negative γ_{AMR} .^{30–35} This was the motivation to achieve the inverse current-perpendicular-to-plane giant magnetoresistance effect in Fe₄N/Ag/Fe structures at RT.⁴¹ In the same manner, we have confirmed a negative sign for P_{σ} in Co₃FeN,³⁴ Fe₃NiN, and FeNi₃N epitaxial films.⁴² In this study, we measured the γ_{AMR} of Fe_{4-x}Mn_xN (x = 0, 1, 2, 3, and 4) films grown on MgO(001) single-crystal substrates and investigated their sign from the magnetotransport properties.

II. METHODS

A. Formation and characterization of Fe_{4-x}Mn_xN films

The 30 nm-thick $Fe_{4-x}Mn_xN$ (x = 0, 1, 2, 3, and 4) epitaxial thin films were grown on MgO(001) single-crystal substrates by MBE using solid sources of Mn and Fe and radio-frequency nitrogen plasma. The substrate temperature (T_{sub}) was varied from 350 to 550 °C to determine the optimum temperature for each composition. The fabrication has been previously detailed in Ref. 25. Nitrogen ions were eliminated by applying bias voltages to the plasma generator, while the Mn/Fe ratio was controlled by the deposition rate (nm/min) based on the crucible temperature of the Knudsen cells. The crystalline quality of the samples was evaluated by reflection high-energy electron diffraction (RHEED) and by out-of-plane and in-plane X-ray diffraction (XRD; Smart-Lab, Rigaku Inc.) measurements with Cu-K α radiation. In the XRD measurements, a Ge(220) single crystal was used to monochromatize the X-ray beam. The magnetization versus magnetic field (M-H) curves were measured by a vibrating sample magnetometer (VSM) at RT. To calculate the sample thickness excluding the surface oxidation layer, we used an X-ray reflectivity measurement. The AMR measurements were performed for $2 \times 6 \text{ mm}^2$ rectangular samples using a physical property measurement system (Quantum Design) equipped with a motorized sample rotator in the temperature T range of 10-300 K. The measurements were performed using the direct-current four-probe method with an external magnetic field (H) of 40 kOe and a current I of 0.1 mA along the [100] axis of the epitaxial layer. The in-plane relative angle ϕ between *H* and *I* was varied from 0° to 360°, and the ϕ dependence of the resistivity $\rho(\phi)$ was measured. The direction of *M* corresponded to that of *H* because the magnitude of *H* was sufficiently large to saturate the sample magnetization.

B. Computational details

We calculated the density of states, the $M_{\rm S}$ values, and the total energy using the Vienna *ab initio* simulation package⁴³ (VASP) via projector augmented wave psedopotenials,44 spin-polarized Perdew-Burke-Ernzerhof generalized gradient approximations,⁴⁵ and Bader charge analysis.⁴⁶ The total energy minimization was obtained via an optimization of the lattice parameters and a relaxation of the atomic positions in a conjugate gradient routine. The convergence in the total energy was better than 10^{-6} eV/f.u. using the energy cutoff of 400 eV. The k-point sampling of $27 \times 27 \times 27$ was used for the calculation of the charge density with VASP. By performing the calculation for structural relaxation, formation energy, lattice parameters (a and c), and spin magnetic moment, the values of $M_{\rm S}$, D, and $P_{\rm D}$ were calculated. We considered two model types for $Fe_{4-x}Mn_xN$ (x = 1, 2, and 3), notated as types A and B, for both Fe₃MnN and FeMn₃N. In a unit cell of type A Fe₃MnN (type A FeMn₃N), Fe (Mn) atoms are positioned at the IIA and IIB sites, while Fe (Mn) atoms occupy the I and IIA sites in type B Fe₃MnN (type B FeMn₃N). Two types of unit cells of Fe₂Mn₂N also exist, whereby Fe₂Mn₂N (corner: Fe) exhibits Fe atoms positioned at the I and IIB sites, while Mn atoms occupy the IIA sites. In a unit cell of Fe₂Mn₂N (corner: Mn), however, Mn atoms occupy the I and IIB sites, and Fe atoms occupy the IIA sites. The calculated $M_{\rm S}$ values and formation energies of the eight types of lattices are summarized in Table I.

III. RESULTS AND DISCUSSION

A. Structural investigation

Figure 2 shows the out-of-plane XRD and RHEED patterns of 30 nm-thick $\text{Fe}_{4-x}\text{Mn}_x\text{N}$ (x = 0, 1, 2, 3, and 4) films grown at $T_{\text{sub}} = 450 \text{ °C}$ for x = 0 and 2, and at $T_{\text{sub}} = 550 \text{ °C}$ for x = 1, 3, and 4. These T_{sub} values were chosen to minimize the full width at half maximum of the $\text{Fe}_{4-x}\text{Mn}_x\text{N}$ 002 diffraction peaks for each sample by ω -scan X-ray rocking

TABLE I. Calculated M_S values and formation energies for Fe_{4-x}Mn_xN compounds with x = 0-4.

Compound	$M_{\rm S}$ (emu/cm ³)	Formation energy (eV/cell)
Fe ₄ N	1698.03	-5.22397
Fe ₃ MnN (type A)	1767.90	-4.98372
Fe ₃ MnN (type B)	771.60	-5.22894
Fe ₂ Mn ₂ N (corner: Fe)	545.33	-5.17169
Fe ₂ Mn ₂ N (corner: Mn)	665.38	-5.37556
FeMn ₃ N (type A)	476.12	-5.28342
FeMn ₃ N (type B)	410.98	-5.49424
Mn ₄ N	211.91	-5.57043



FIG. 2. Out-of-plane XRD and RHEED patterns of $Fe_{4-x}Mn_xN$ along the MgO[100]. The arrows indicate the position of superlattice diffraction lines.

curve measurements. Streaky RHEED patterns and *c*-axisoriented XRD diffraction peaks corresponding to the nitride phase were observed for all samples. These results demonstrate that single-phase nitrides were epitaxially grown on the MgO(001) substrates. In the RHEED patterns shown in Fig. 3, superlattice diffractions from N atoms at the bodycentered site (arrows in Fig. 3) were clearly observed in the Mn₄N, Fe₃MnN, and Fe₄N films, indicating that the N atoms were long-range ordered, whereas those lines were blurred in the FeMn₃N and Fe₂Mn₂N films. In the XRD patterns, such superlattice peaks appeared in all of the samples, demonstrating the presence of N atoms at the correct positions in these films. The *c*-axis-oriented diffraction peaks of $Fe_{4-x}Mn_xN$ shifted to lower angles with the Mn content, signifying that the lattice constant *c* increased. This shift is the result of the Mn₄N possessing a larger lattice constant than that of Fe₄N. As an index for N atoms to be correctly located at the body-centered sites, we employed the degree of order of N (*S*). *S* is defined as the correctness of the N atom location, namely, the occupation probability is (1 + 3S)/4 for the assigned body-centered site and is determined as³³

$$S = \sqrt{\frac{I_{100}^{\text{obs}}/I_{200}^{\text{obs}}}{I_{100}^{\text{cal}}/I_{200}^{\text{cal}}}},$$
(2)

$$I_{hkl}^{\text{cal}} = LP \cdot \Psi \cdot F_{hkl}^2 \cdot \exp\left(-2B\frac{\sin^2\theta}{\lambda^2}\right),\tag{3}$$

where I_{hkl}^{obs} and I_{hkl}^{cal} are the integrated XRD intensities of the *hkl* reflection obtained by experiment and calculation, respectively; *LP* is the Lorentz-polarization factor for a single crystal; Ψ is the powder ring distribution factor;⁴⁷ and the exponential term is the Debye-Waller factor, where *B* is the temperature factor, F_{hkl} is the structure factor of the Mn_{4-x}Fe_xN unit cell for *hkl* diffraction, and λ is the wavelength of x-ray used ($\lambda = 0.15418$ nm). For an in-plane geometry, Ψ was obtained using Eq. (5) in Ref. 47, where the equipment parameter s_2 was fixed as 3.3° by using the angular divergence of the detector window. Herein, *LP* was calculated by

$$LP = \frac{1 + \cos^2(2\theta)\cos^2(2\theta_{\rm M})}{\sin 2\theta \{1 + (\cos^2\theta_{\rm M})\}} , \qquad (4)$$

where θ_M is the Bragg angle of the monochromator. Considering its crystalline structure, F_{hkl} of Mn₄N is



FIG. 3. Calculated spin-resolved partial D and total D of $Fe_{4-x}Mn_xN$ (x = 0, 1, 2, 3, and 4). Calculated values of P_D at E_F are presented.

defined as

$$F_{hkl} = f_{Mn} \{ 1 + (-1)^{h+k} + (-1)^{k+l} + (-1)^{l+h} \}$$

+ $f_{N} (-1)^{h+k+l}.$ (5)

Here, f_{Mn} and f_N are the atomic scattering factors of Mn and N atoms, respectively. In $Mn_{4-x}Fe_xN$, we estimated that the Mn and Fe atoms were randomly distributed at the I and II sites, and thus, F_{hkl} of $Mn_{4-x}Fe_xN$ was calculated using

$$F_{hkl} = \left\{ \frac{x \cdot f_{\text{Fe}} + (4 - x) \cdot f_{\text{Mn}}}{4} \right\} \{1 + (-1)^{h+k} + (-1)^{k+l} + (-1)^{l+h}\} + f_{\text{N}}(-1)^{h+k+l}.$$
(6)

Here, $f_{\rm Fe}$ is the atomic scattering factor of Fe atom. The parameter B was calculated by rearranging Eq. (3) and obtaining $-2B = \ln[I_{obs}/\{F_{hkl}^2 \cdot LP \cdot \Psi\}]/(\sin\theta/\lambda)^2$, where I_{obs} is the integrated intensity of the experimentally obtained diffraction peak. Herein, we calculated B by logarithmically plotting the I_{obs} of the 200, 220, and 400 diffractions as a function of their angles and fitting the curves using the least squares method. S values together with the ratio of the perpendicular lattice constant c to the in-plane lattice constant a(c/a) were summarized in Table II. The values of c/a were found to be 1.005 in Fe₄N, 0.985 in Fe₂Mn₂N, 0.986 in FeMn₃N, and 0.991 in Mn₄N. This means the presence of an in-plane tensile strain at RT, and thus, the tetragonal distortion exists. We should notice that the S value was as small as approximately 0.5 in the Fe₂Mn₂N and FeMn₃N films. We attribute such small S values to crystal imperfections in these films. This is apparent from the blurred RHEED patterns of these films as shown in Fig. 2.

B. Calculation results

Here, we present the calculation results for *D* and M_s in the Fe_{4-x}Mn_xN according to the *ab initio* calculations. Several metastable states possessing different M_s values were calculated for the three Fe_{4-x}Mn_xN compositions with x = 1, 2, and 3. In the Fe_{4-x}Mn_xN with x = 1, the energy of the calculated lowest energy state of the Fe₃MnN (type B) was lower than that of the Fe₃MnN (type A) (Table I). Hence, the lowest energy state for the Fe₃MnN (type A) is a metastable state within the same compositional Fe₃MnN, and therefore, this calculated result recommends the Fe₃MnN (type B) structure. Similarly, in the Fe_{4-x}Mn_xN with x = 2 and 3, the

TABLE II. Values of c/a obtained from XRD analysis and degree of order (*S*) of N site for Fe_{4-x}Mn_xN compounds with x = 0-4.

Compound	cla	S
Fe ₄ N	1.005	0.82
Fe ₃ MnN	1.001	0.68
Fe ₂ Mn ₂ N	0.985	0.52
FeMn ₃ N	0.986	0.55
Mn_4N	0.991	0.70

structures possessing type B and corner Mn are the most stable structures within the same $Fe_{4-x}Mn_xN$ composition.

Figure 3 shows the calculated spin-resolved partial Dand total D values for the lowest energy state of each $Fe_{4-x}Mn_xN$ (x = 0, 1, 2, 3, and 4) structure. The calculated values of $P_{\rm D}$ at $E_{\rm F}$ (E=0) are also represented. With the increase of Mn content x, the exchange splitting decreases and the $E_{\rm F}$ shifts deep into the \uparrow -spin bands. The $P_{\rm D}$ values for the Fe₄N [Fig. 3(a)] and Mn₄N [Fig. 3(h)] are a negative value of -0.5 and a positive value of +0.44, respectively. The total D value of the Fe_3MnN (type A) [Fig. 3(b)] is similar to that of the Fe₄N [Fig. 3(a)], and the $P_{\rm D}$ value is negative. In this structure, the d states at Fe are representative at the $E_{\rm F}$. Meanwhile, the total D values for the other $Fe_{4-x}Mn_xN$ (x = 1, 2, and 3) structures [Figs. 3(c)-3(g)] are similar to those calculated for the Mn₄N [Fig. 3(h)], and all $P_{\rm D}$ values are positive. The values of $P_{\rm D}$ for Fe₂Mn₂N (corner Mn) and FeMn₃N (type B), which are the most stable structures, respectively, for x = 2 and 3 for $Fe_{4-x}Mn_xN$, are as large as +0.36 and +0.43, respectively. However, the absolute values of $P_{\rm D}$ for the Fe₂Mn₂N (corner Fe) and the FeMn₃N (type A), which are not the most stable structures within the same compositional $Fe_{4-x}Mn_xN$, are as small as 0.09 and 0.06, respectively. In these five structures, the d states at Mn are representative at the $E_{\rm F}$. It should also be noted in Fig. 3 that the $E_{\rm F}$ is located close to the energy where the total D reaches a maximal value in Fe₄N and Mn₄N. This result suggests that the $P_{\rm D}$ is considered sensitive to T in these materials.

Figure 4 shows the calculated M_S values associated with the structure for the density of states *D* shown in Fig. 3, alongside the measured values of M_S (closed squares in Fig. 4). With the exception of the Fe₃MnN (type A), the calculated M_S of Fe_{4-x}Mn_xN decreases with increasing *x* value, which is consistent with the experimentally measured values. The M_S value of Fe₃MnN (type A) (1767.90 emu/cm³) is larger than that of Fe₄N (1698.03 emu/cm³), but the energy of the state of Fe₃MnN (type A) is larger than that of the lowest energy state of Fe₃MnN (type B). Therefore, considering both the calculated energy for each Fe₃MnN type and the comparison between the calculated and measurement magnetization, the Fe_{4-x}Mn_xN (type B and corner: Mn) structures are recommended. The deviation of the measured M_S values



FIG. 4. Calculated (hollow circles) and experimentally obtained (solid squares) saturation magnetization M_S values of Fe_{4-x}Mn_xN films as a function of x at room temperature.

from those calculated was distinct in Fe_4N , Fe_2Mn_2N , and $FeMn_3N$. We attribute this deviation to crystal imperfections in these films with reduced *S* values as shown in Table II.

C. Temperature dependence of the AMR effect

Figure 5 shows the AMR curves of $Fe_{4-x}Mn_xN$ epitaxial films with a current I set along the [100] axis of the epitaxial layer, given by the angular dependence of the resistivity change normalized by $\rho(90^\circ)$ such that $[\rho(\phi) - \rho(90^\circ)]/\rho(90^\circ)$. The AMR ratio γ_{AMR} is obtained at $\phi = 0^{\circ}$ and 180°. It is apparent that these curves significantly depend on both T and ϕ . As will be discussed later, these curves can be fitted using the two cosine functions of $\cos(2\phi)$ and $\cos(4\phi)$. Examining the AMR curves in Fig. 5 is apparent that the $\cos(4\phi)$ component is dominant in Mn₄N. A similar result has been previously reported in Ref. 17. In-depth discussions about the origin of the ϕ dependence of γ_{AMR} are provided in Refs. 28 and 29. Briefly, it originates from the dependence of the electron occupation of 3d orbitals on the direction of magnetic moment with respect to the crystal axes. This is because the AMR effect is attributed to the spin-orbit interaction, which causes spin mixing in the scattering process of conduction electrons into 3*d* orbitals.^{48,49} The $\cos(2\phi)$ term arises from the twofold symmetry of 3d orbitals due to the spin-orbit interactions.²⁸ On the other hand, the $\cos(4\phi)$ term is attributed to the fourfold symmetry of 3d orbitals caused by the tetragonal distortion.²⁹ The presence of tetragonal distortion was confirmed in Fe₄N by the transverse AMR effect,⁴⁰ where the magnetization vector was rotated in the orthogonal plane to the current direction.

Figure 6 shows the T dependences of γ_{AMR} . The sign of γ_{AMR} is positive for Fe₃MnN and Fe₂Mn₂N at $T \leq 300$ K but is negative for Fe₄N and FeMn₃N at $T \le 300$ K. Regarding Mn₄N, γ_{AMR} is positive at 300 K and negative at $T \leq 100$ K. The signs of all of the calculated γ_{AMR} values are summarized in Table III. We next deduced the sign of P_{σ} using Eq. (1). Because 0 K is assumed in the calculation, our discussion on the sign of P_{σ} is limited to low temperatures. From Eq. (1), when $P_{\rm D}$ and $\gamma_{\rm AMR}$ have the same sign, the sign of P_{σ} is negative, and when P_{D} and γ_{AMR} exhibit opposite signs, the sign of P_{σ} is positive. These results can be seen in Table III, where P_{σ} is negative for Fe₄N, Fe₃MnN, and Fe₂Mn₂N, and is positive for FeMn₃N and Mn₄N. We therefore can posit that minority spin conduction is dominant in Fe₄N, Fe₃MnN, and Fe₂Mn₂N, whereas majority spin conduction is dominant in FeMn₃N and Mn₄N. These results demonstrate the gradual change from a negative P_{σ} in Fe₄N (i.e., x = 0) to a positive P_{σ} in Mn₄N (i.e., x = 4) with increasing x in $Fe_{4-x}Mn_xN$ (Table III).

Figure 7 shows the Fourier coefficients of the AMR curves obtained for $Fe_{4-x}Mn_xN$ using the least squares fitting method with

$$[\rho(\phi) - \rho(90^{\circ})] / \rho(90^{\circ}) = C_0 + C_2 \cos(2\phi) + C_4 \cos(4\phi),$$
(7)

where C_2 and C_4 are the Fourier coefficients of the $cos(2\phi)$ and $cos(4\phi)$ components, respectively, and C_0 (= $C_2 - C_4$) is



FIG. 5. Anisotropic magnetoresistance $[\rho(\phi) - \rho(90^\circ)]/\rho(90^\circ)$ curves of (a) Fe₄N, (b) Fe₃MnN, (c) Fe₂Mn₂N, (d) FeMn₃N, and (e) Mn₄N films measured in the 300–10 K temperature range. The sensing current was set along the [100] axis of the grown films.



FIG. 6. γ_{AMR} values of the Fe_{4-x}Mn_xN films as a function of temperature.

a constant. The derivation of Eq. (7) is presented, for example, in Ref. 42. Although this equation was originally derived from the phenomenological expressions,⁵⁰ Kokado and Tsunoda derived Eq. (7) from the framework of transport theory and gave the physical explanations to it.²⁹ It was reported that C_4 appears under the crystal field of tetragonal symmetry at low temperatures, whereas it vanishes under the crystal field of cubic symmetry. The tetragonal distortion is assumed to originate from the anisotropic thermal compression of the lattice caused by the adhesion between the grown layer and the MgO substrate. Furthermore, γ_{AMR} directly relates to C_2 such that $\gamma_{AMR} = 2C_2$. Thereby, we are able to understand the *T* dependence of γ_{AMR} and the degree of the tetragonal distortion in Fe_{4-x}Mn_xN films by obtaining the *T* dependence of C_2 and C_4 .

First, we discuss the C_2 term. As shown in Fig. 7, the decrease in $|C_2|$ with increasing T was observed for all samples except Fe₂Mn₂N, leading to the reduction in $|\gamma_{AMR}|$ at higher T as shown in Fig. 6. We ascribe the decrease in $|C_2|$ thereby $|\gamma_{AMR}|$ with an increase of T to the decrease in $|P_D|$ and $|P_{\sigma}|$ in Eq. (1). In Fig. 7, there is a distinct difference in C_2 values between the Fe₄N and Mn₄N structures. Specifically, in Fe_4N ,^{33,34} the C_2 is negative over the entire T range and the $|C_2|$ begins to significantly increase at T < 100 K. We speculate that such a drastic change in $|C_2|$ in Fe₄N is attributed to the fact that the total D reaches a maximal value at around $E_{\rm F}$ as shown in Fig. 3(a), and thus the $P_{\rm D}$ is sensitive to T. Conversely, in Mn_4N , the C_2 is positive at 300 K but changes to a negative value at lower T. Similar result was obtained previously.¹⁷ The C_2 is negative in FeMn₃N, and the $|C_2|$ shows a gradual increase with decreasing T. In Fe₂Mn₂N with a small S value, however, the C_2 value

TABLE III. Signs of the γ_{AMR} , P_D at E_F , and P_σ parameters in Fe_{4-x}Mn_xN.

Compound	$\gamma_{ m AMR}$	$P_{\rm D}$ at $E_{\rm F}$	Po
Fe ₄ N	_	_	_
Fe ₃ MnN (type B)	+	+	-
Fe ₂ Mn ₂ N (corner: Mn)	+	+	-
FeMn ₃ N (type B)	_	+	+
Mn ₄ N	_	+	+

does not significantly change across the whole T range. Kabara et al. systematically investigated the influence of S on the C_2 and C_4 terms in Fe₄N and found that with decreasing S the enhancement of C_2 at low temperatures gradually decreased, and C_4 vanished.³³ Therefore, it can be stated that the crystal field effect can be deteriorated by the reduction of S thereby crystal imperfections. Here, we discuss the sign of C_2 in more detail mainly on Fe₄N and Mn₄N using Fig. 8. The 3d orbitals of Fe₄N are split into the two states d_{ε} and d_{γ} by a cubic crystal field effect. These states are then further split into finer states such as $d_{\varepsilon} \rightarrow d_{\delta \varepsilon}$ (d_{xy}, d_{yz}, d_{zx}) and $d_{\gamma} \rightarrow d_{3z^2 - r^2}, d_{x^2 - y^2}$ by a tetragonal distortion.²⁹ Here, it is assumed that the sample and the magnetic moment M are on the x-y plane and the current I flows in the x-direction. ϕ is the relative angle between I and M. According to Ref. 29, when the dominant s-d scattering process is $s_{\uparrow(\downarrow)} \rightarrow d_{\downarrow(\uparrow)}$, which signifies that the $\uparrow(\downarrow)$ -spin conduction electrons are scattered into $\downarrow(\uparrow)$ -spin d bands, the C_2 is described as

$$C_2^{s_{\uparrow(\downarrow)} \to d_{\downarrow(\uparrow)}} \propto \left(\frac{\lambda}{H_{\text{ex}} - \Delta}\right)^2 D_{\xi_{\uparrow\downarrow(\uparrow)}},$$
 (8)

where Δ and $D_{\xi,\varsigma}$ are the energy difference between the d_{ε} and d_{γ} states, and the partial D of the d_{ξ} orbital in the d_{ε} states with ς -spin at $E_{\rm F}$, respectively. In this case, C_2 is always positive. Conversely, in the case where the $s_{\uparrow(\downarrow)} \rightarrow d_{\uparrow(\downarrow)}$ scattering process is dominant, the dominant term in C_2 is proportional to the difference in the partial D at $E_{\rm F}$ between the d_{ε} and d_{γ} states, and is described as

$$C_2^{s_{\uparrow(\downarrow)} \to d_{\uparrow(\downarrow)}} \propto \left(\frac{\lambda}{\Delta}\right)^2 (D_{\gamma,_{\uparrow(\downarrow)}} - D_{\delta \varepsilon,_{\uparrow(\downarrow)}}), \tag{9}$$

where $D_{\gamma(\delta\varepsilon),\zeta}$ is the partial D of the $d_{\gamma(\delta\varepsilon)}$ orbital with a ς -spin at $E_{\rm F}$. Because C_2 is negative for Fe₄N at $T \leq 300$ K and the $|C_2|$ value increases with the decrease of T, we assume from Eq. (4) that the partial D of the d_{γ} states in that structure is smaller than that of the d_{ε} states at $E_{\rm F}$, and the $|D_{\gamma,t(0)} - D_{\delta \varepsilon,t(0)}|$ increases with decreasing T. As the P_{σ} is negative in Fe₄N, as shown in Table III, the \downarrow -spin electrons dominate the electrical conduction and are scattered into \downarrow -spin *d* bands. In the case of ferrimagnetic Mn₄N, however, additional theoretical considerations are required.¹⁷ This is because the magnetic moment of Mn atoms at I sites is antiparallel to that at II sites.¹ Mn atoms thus can be grouped into two from the viewpoint of magnetic moment. They are named sublattices A and B, corresponding to the lattices composed of Mn atoms at I sites and II sites, respectively. Thus, Eqs. (8) and (9) are, respectively, modified to¹⁷

$$C_{2}^{s_{\uparrow(\downarrow)} \to d_{\downarrow(\uparrow)}} \propto \left(\frac{\lambda}{H_{\rm A} - \Delta}\right)^{2} D_{{\rm A},\xi_{\downarrow(\uparrow)}} + \left(\frac{\lambda}{-H_{\rm B} - \Delta}\right)^{2} D_{{\rm B},\xi_{\uparrow\downarrow(\uparrow)}}, \tag{10}$$

$$C_{2}^{s_{\uparrow(\downarrow)} \to d_{\uparrow(\downarrow)}} \propto \left(\frac{\lambda}{\Delta}\right)^{2} \left\{ (D_{A,\gamma_{\uparrow(\downarrow)}} + D_{B,\gamma_{\uparrow(\downarrow)}}) - (D_{A,\delta\varepsilon_{\uparrow(\downarrow)}} + D_{B,\delta\varepsilon_{\uparrow(\downarrow)}}) \right\},$$
(11)



FIG. 7. Fourier coefficients C_2 and C_4 of the $[\rho(\phi) - \rho(90^\circ)]/\rho(90^\circ)$ curves of (a) Fe₄N, (b) Fe₃MnN, (c) Fe₂Mn₂N, (d) FeMn₃N, and (e) Mn₄N films measured in the temperature range 300–10 K.

where $H_{A(B)}$ is the exchange splitting of the sublattice A(B) and $D_{A(B),\xi(\gamma,\delta\varepsilon),\varsigma}$ is the partial D of the $d_{\xi}(d_{\gamma}, d_{\delta\varepsilon})$ orbital with ς -spin at $E_{\rm F}$. The change in the sign of C_2 obtained for Mn₄N is explained by Eq. (11). The negative C_2 at low T means that $(D_{A,\gamma,\uparrow(\downarrow)}+D_{B,\gamma,\uparrow(\downarrow)})$ is smaller than $(D_{A,\delta\varepsilon,\uparrow(\downarrow)}+D_{B,\delta\varepsilon,\uparrow(\downarrow)})$. This magnitude correlation is reversed at high T like RT because of the shift of $E_{\rm F}$, leading to the positive C_2 . Because the P_{σ} is positive in Mn₄N, as shown in Table III and Refs. 51 and 52, the *↑*-spin electrons dominate the electrical conduction and are scattered into \uparrow -spin d bands. As for the intermediate materials such as FeMn₃N, Fe₂Mn₂N, and Fe₃MnN, their electrical conduction is interpreted in the following way. In FeMn₃N, the \uparrow -spin electrons dominate the electrical conduction because of $P_{\sigma} > 0$ and are scattered into \uparrow -spin d bands just like in Mn₄N because of $D_{\uparrow}^{(d)} > D_{\downarrow}^{(d)}$. Here, $D^{(d)}_{\uparrow}[D^{(\bar{d})}_{\downarrow}]$ is the \uparrow -spin (\downarrow -spin) D for 3d electrons at $E_{\rm F}$. With increasing the Fe content further in Fe₂Mn₂N and Fe₃MnN, $D_{\perp}^{(d)}$ becomes smaller than $D_{\perp}^{(d)}$. Considering that the $P_{\rm D}$ is positive but the P_{σ} is negative in those materials, the ↓-spin electrons dominate the electrical conduction and are scattered into \downarrow -spin *d* bands. When the Fe content



FIG. 8. Schematic energy levels of the 3d states in the tetragonal crystal field.²⁹

increases much further in Fe₄N, the \downarrow -spin electrons govern the electrical conduction due to $P_{\sigma} < 0$ and are scattered into \downarrow -spin *d* bands because of $D_{\uparrow}^{(d)} < D_{\downarrow}^{(d)}$. The above change in electrical conduction is likely caused by an increase in both exchange splitting and in $E_{\rm F}$ with increasing the Fe content.

Next, we consider the C_4 term. The dominant term in C_4 is proportional to the difference in the partial D at $E_{\rm F}$ among the d_{ε} states in Fig. 8.²⁹ The energy separation of the d_{ε} state into d_{yy} , d_{yz} , and d_{zx} states is caused by the tetragonal distortion. Therefore, the increase in $|C_4|$ with the decrease of T indicates the increase of the tetragonal distortion. The Fe₄N | C_4 value only appears below 100 K as reported in Ref. 31. The Mn₄N $|C_4|$ value begins to increase around 100 K to reach a value of 1.5% at 10 K, which is more than seven times greater than the $Mn_4N |C_2|$ value. As reported in Refs. 13, 16, 18, 25, and 52, the in-plane tensile stress exists in the Mn₄N films, and therefore, the c/a value is smaller than 1 at RT, signifying tetragonal distortion in Mn_4N . A sharp increase of $|C_4|$ was also observed in FeMn₃N (c/a = 0.986) (Ref. 25) in Fig. 7(d). In contrast, the C₄ value was almost 0 in Fe₃MnN and Fe₂Mn₂N over the whole T range in Figs. 7(b) and 7(c) even though the Fe_2Mn_2N film contained a higher tensile stress (c/a = 0.985) than that in the Mn_4N film (c/a = 0.9991) at RT.²⁵ It was reported that the lattice constant c of Fe₄N films decreased by 0.5% at 10 K compared to that at 300 K.31 Thereby, it is still uncertain why such a small change in lattice constants causes a sharp increase of $|C_4|$ in Fe₄N. Thus, further theoretical and experimental investigations are mandatory to explain the T and ϕ dependences of C_2 and C_4 in more detail and especially to get the origin of C_4 .

IV. CONCLUSION

We measured the AMR effect of 30 nm-thick $Fe_{4-x}Mn_xN$ (x = 0, 1, 2, 3, and 4) epitaxial films grown on MgO(001) substrates by MBE and investigated their magnetotransport properties at temperatures between 10 and 300 K. Experimentally measured saturation magnetizations were in agreement with those obtained by *ab initio* calculation. A positive AMR ratio was observed in Fe₃MnN and Fe₂Mn₂N

films, whereas Fe₄N, FeMn₃N, and Mn₄N films exhibited negative AMR ratios. The AMR ratio was negative in Fe₄N at $T \leq 300$ K, while the AMR ratio changed from positive to negative in Mn₄N at lower temperatures. Considering the sign of the spin polarization of the density of states at $E_{\rm F}$ calculated for $Fe_{4-x}Mn_xN$ (x = 0, 1, 2, 3, and 4), minority spin transport is dominant in Fe₄N, Fe₃MnN, and Fe₂Mn₂N, while majority spin transport is dominant in FeMn₃N and Mn₄N. We also discussed the twofold and fourfold symmetries obtained in the AMR curves. The fourfold symmetry became pronounced at low temperatures in Fe₄N and FeMn₃N, and especially in Mn₄N. This effect was interpreted to originate from the tetragonal distortion; however, uncertainties remain about its origin. Thus, further investigations are mandatory especially to understand the origin of the fourfold symmetry in AMR curves.

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